



InAsSb photovoltaic detector arrays

P15742 series

16, 46 element array capable of detecting up to 5 µm band

The P15742 series is one-dimensional InAsSb photovoltaic detector array in a ceramic DIP (dual inline package). They have a back-illuminated structure that achieves low crosstalk. These are environmentally friendly infrared detectors that do not use lead, mercury, or cadmium, which are substances restricted by the RoHS Directive.

Features

- → High sensitivity
- Low crosstalk
- RoHS compliant (lead, mercury, cadmium free)

Applications

- Infrared spectrophotometry
- **■** Temperature measurement
- → Remote sensing

Structure

Parameter	P15742-016DS	P15742-046DS	Unit
Number of elements	16	46	-
Element size	0.45 × 0.7	0.2 × 0.7	mm
Element pitch	0.5	0.25	mm
Package	18-pin ceramic DIP	48-pin ceramic DIP	-
Window material	Sapphire		

♣ Absolute maximum ratings (Ta=25 °C, unless otherwise noted)

Parameter	Symbol	Condition	Value	Unit
Reverse voltage	VR		1	V
Operating temperature	Topr	No dew condensation*1	-20 to +70	°C
Storage temperature	Tstg	No dew condensation*1	-20 to +80	°C

^{*1:} When there is a temperature difference between a product and the surrounding area in high humidity environments, dew condensation may occur on the product surface. Dew condensation on the product may cause deterioration in characteristics and reliability.

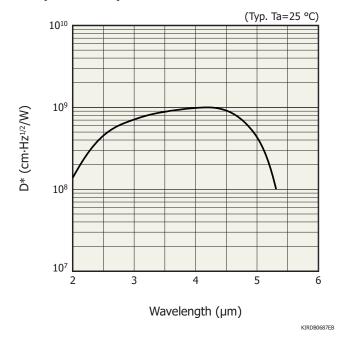
■ Electrical and optical characteristics (Ta=25 °C, per element)

Parameter	Symbol Con	Condition	P1	15742-016DS		P15742-046DS		Unit	
Parameter		Condition	Min.	Тур.	Max.	Min.	Тур.	Max.	Offic
Peak sensitivity wavelength	λр		-	4.1	-	-	4.1	-	μm
Cutoff wavelength	λс		5	5.3	-	5	5.3	-	μm
Photosensitivity	S	λ=λρ	5	6.5	-	11.6	14.6	-	mA/W
Shunt resistance	Rsh	VR=10 mV	70	180	-	24	60	-	kΩ
Detectivity	D*	(λρ, 1200, 1)	8×10^{8}	1×10^{9}	-	8×10^{8}	1×10^{9}	-	cm·Hz ^{1/2} /W
Rise time	tr	VR=0 V, RL=50 Ω 10 to 90%, λ=1.55 μm	-	15	-	-	15	-	ns
Terminal capacitance	Ct	VR=0 V, f=1 MHz	-	40	-	-	50	-	pF
Noise equivalent power	NEP	λ=λρ	-	5.6 × 10 ⁻¹¹	7 × 10 ⁻¹¹	-	4.2 × 10 ⁻¹¹	5.3 × 10 ⁻¹¹	W/Hz ^{1/2}

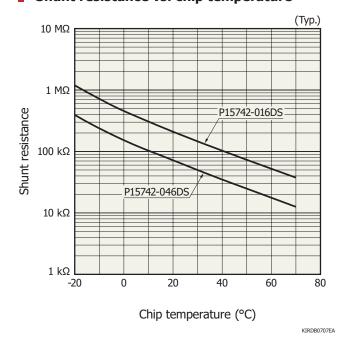
Note: Uniform irradiation on the entire photosensitive area

Note: Exceeding the absolute maximum ratings even momentarily may cause a drop in product quality. Always be sure to use the product within the absolute maximum ratings.

Spectral response



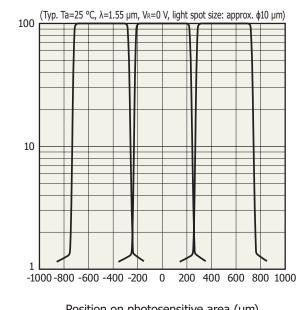
Shunt resistance vs. chip temperature



- Crosstalk characteristics

Relative sensitivity (%)

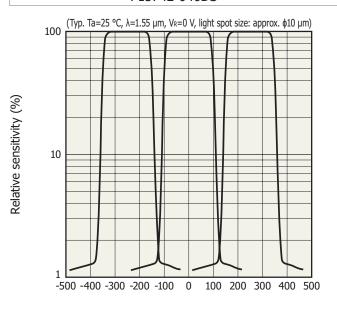
P15742-016DS



Position on photosensitive area (μm)

KIRDB0708EA

P15742-046DS

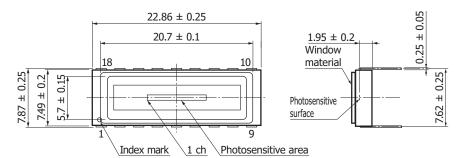


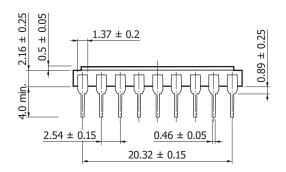
Position on photosensitive area (µm)

KIRDB0709EA

Dimensional outlines (unit: mm)

P15742-016DS

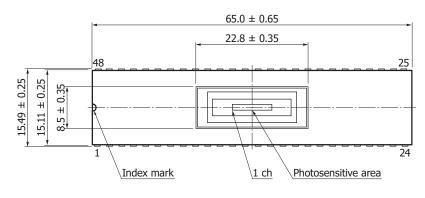


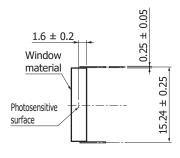


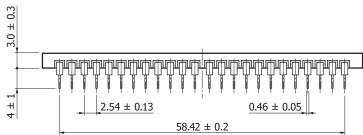
Chip position accuracy with respect to package center X, $Y \le \pm 0.3$, $\theta \le \pm 3^{\circ}$

KIRDA0270EA

P15742-046DS



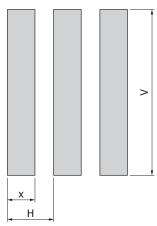




Chip position accuracy with respect to package center X, Y \leq ±0.3, θ \leq ±3°

KIRDA0271EA

▶ Details of photosensitive area (unit: mm)



Number of elements	х Н		V
16	0.45	0.5	0.7
46	0.2	0.25	0.7

KIRDC0131EA

- Pin connections

Pin no.	P15742-016DS	P15742-046DS	Pin no.	P15742-016DS	P15742-046DS
1	KC	KC	25	/	KC
2	2	2	26] / [45
3	4	4	27] / [43
4	6	6	28] / [41
5	8	8	29] / [39
6	10	10	30] / [37
7	12	12	31] / [35
8	14	14	32	/	33
9	16	16	33] / [31
10	KC	18	34] / [29
11	15	20	35] / [27
12	13	22	36] / [25
13	11	24	37] / [23
14	9	26	38] / [21
15	7	28	39] / [19
16	5	30	40] / [17
17	3	32	41] / [15
18	1	34	42] / [13
19		36	43		11
20		38	44] / [9
21		40	45] /	7
22		42	46] /	5
23		44	47] /	3
24		46	48	V	1

Note: KC: cathode (common), other than cathode: anode

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Recommended soldering conditions

Solder temperature: 260°C (5 s or less, once)

Solder the leads at a point at leat 1.5mm away from the package body.

Note: When you set soldering conditions, check that problems do not occur in the product by testing out the conditions in advance.

Related information

www.hamamatsu.com/sp/ssd/doc_en.html

- Precautions
- Disclaimer
- · Safety consideration
- · Compound opto-semiconductors (photosensors, light emitters)
- Technical note
- · Compound semiconductor photosensors

Information described in this material is current as of September 2023.

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